



PLUTO Safety-PLC

Operating instructions

Hardware

Safety parameters

SIL according to IEC 61508	SIL 3
SIL according to EN 62061	SIL CL 3
PL according to EN ISO 13849-1	PL e
Category according to EN ISO 13849-1	4
DC _{avg} according to EN ISO 13849-1	High
CCF according to EN ISO 13849-1	Meets the requirements
HFT (Hardware fault tolerance)	1
SFF (Safe failure fraction)	>99% for the single channel parts
	>90% for the double channel parts

Digital input to Safety output *

PFD _{AV} (for proof test interval = 20 years)	1.5×10^{-4}
PFH _D according to IEC 61508/EN 62061	2×10^{-9}
MTTF _d according to EN ISO 13849-1	High/1100 years

Analogue inputs to Safety output

(Pluto D20, D45)	2 inputs/sensors (see 4.3.2)	1 input/sensor (see 4.3.2)
SIL according to IEC 61508/EN 62061	Up to SIL 3	Up to SIL 2
PL according to EN ISO 13849-1	Up to PL e	Up to PL d
DC _{avg} according to EN ISO 13849-1	Up to High	Up to Medium
PFD _{AV} (for proof test interval = 20 years)	1.5×10^{-4}	1.5×10^{-3}
PFH _D according to IEC 61508/EN 62061	1.6×10^{-9}	5.8×10^{-9}
MTTF _d according to EN ISO 13849-1	High/1100 years	High/400 years

Counter inputs to Safety output

(Pluto D45)	2 inputs/sensors (see 4.4.7)	1 input/sensor (see 4.4.7)
SIL according to IEC 61508/EN 62061	Up to SIL 3	Up to SIL 1
PL according to EN ISO 13849-1	Up to PL e	Up to PL c
DC _{avg} according to EN ISO 13849-1	Up to High	Up to High
PFD _{AV} (for proof test interval = 20 years)	1.5×10^{-4}	1.5×10^{-4}
PFH _D according to IEC 61508/EN 62061	1.6×10^{-9}	1.6×10^{-9}
MTTF _d according to EN ISO 13849-1	High/1100 years	High/1100 years

Note:

PFD_{AV} = Average probability of dangerous failure on demand

PFH_D = Probability of dangerous failure per hour

MTTF_d = Mean time to dangerous failure/channel

PL = Performance level (as defined in EN ISO 13849-1)

CCF = Common cause failure

*Input to output (incl. AS-i and CAN bus)